Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10643672	RAY ET AL.	
Examiner	Art Unit	
Chawan, Sheela C	2624	

SEARCHED				
Class	Subclass	Date	Examiner	
382	103,118,199,190,305	12/22/06	SCC	
709	204,205	12/22/06	SCC	
355	75	12/22/06	SCC	
715	759,753	12/22/06	SCC	
370	260	12/22/06	SCC	
379	202.01	12/22/06	SCC	
34	117	12/22/06	SCC	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST, US-PGPUB,USPAT,EPO,JPO,DERWENT,IBM-TDB.	12/22/06	SCC		
INVENTOR NAME SEARCH.	12/22/06	SCC		

Date	Examine
	Date